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# 1 $\Omega$ R<sub>ON</sub> DPST and Dual SPST Switches

The NLAS5213A and NLAS5213B are DPST and Dual SPST devices, respectively. They each consist of 2 single throw switches and are both designed for audio applications within portable devices. The NLAS5213A is controlled with a single enable pin while the NLAS5213B has two independent enables.

Both the NLAS5213A and NLAS5213B operate over a wide  $V_{CC}$  range, 1.65 V to 4.5 V, and maintain a very low  $R_{ON}$ : 1.3  $\Omega$  Max @  $V_{CC}$  = 4.2 V. Each is available in a choice of two packages: US8 and UDFN8.

#### **Features**

- PST and Dual SPST Pinouts
- $R_{ON}$ : 1.3  $\Omega$  Max @  $V_{CC}$  = 4.2 V
- V<sub>CC</sub> Range: 1.65 V to 4.5 V
- 8 kV Human Body Model ESD on I/O to GND
- UDFN8 or US8 Packages Available
- These are Pb-Free Devices

#### **Typical Applications**

- Mobile Phones
- Portable Devices

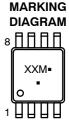


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US8 US SUFFIX CASE 493





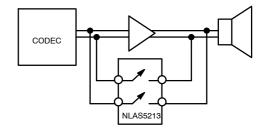
UDFN8 MU SUFFIX CASE 517AJ



XX = Device Code
M = Date Code
Device Pb-Free Package

(Note: Microdot may be in either location)

#### **APPLICATION DIAGRAM**



#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 9 of this data sheet.

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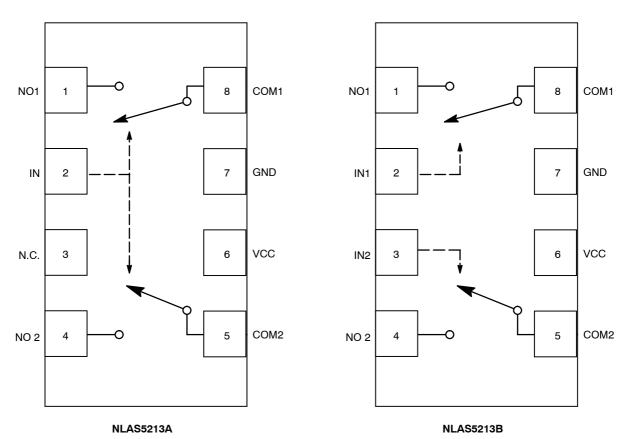


Figure 1. Functional Block Diagram Pinouts (UDFN8)

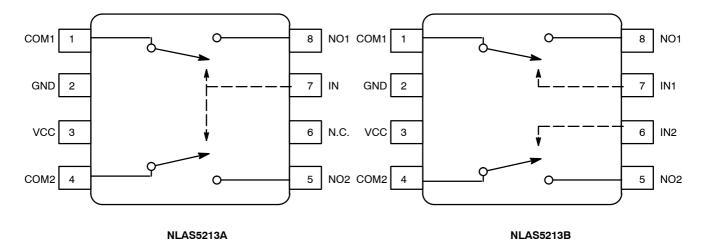


Figure 2. Functional Block Diagram Pinouts (US8)

#### NLAS5213A

Pi	n #					
UDFN8	US8	Name	Direction	Description		
1	8	NO1	I/O	Normally Open Signal Line of Switch 1		
2	7	IN	Input	Control Input		
3	6	N.C.	N/A	No Connect		
4	5	NO2	I/O	Normally Open Signal Line of Switch 2		
5	4	COM2	I/O	Common Signal Line of Switch 2		
6	3	V <sub>CC</sub>	Input	Analog Supply Voltage		
7	2	GND	Input	Ground		
8	1	COM1	I/O	Common Signal Line of Switch 1		

#### NLAS5213B

Pi	n #			
UDFN8	US8	Name	Direction	Description
1	8	NO1	I/O	Normally Open Signal Line of Switch 1
2	7	IN1	Input	Control Input of Switch 1
3	6	IN2	Input	Control Input of Switch 2
4	5	NO2	I/O	Normally Open Signal Line of Switch 2
5	4	COM2	I/O	Common Signal Line of Switch 2
6	3	V <sub>CC</sub>	Input	Analog Supply Voltage
7	2	GND	Input	Ground
8	1	COM1	I/O	Common Signal Line of Switch 1

#### **NLAS5213A FUNCTION TABLE**

IN	NO1, NO2
0	OFF
1	ON

#### **NLAS5213B FUNCTION TABLE**

IN	NO1, NO2
0	OFF
1	ON

#### **OPERATING CONDITIONS**

#### **MAXIMUM RATINGS**

Symbol	Pins	Parameter	Value	Condition	Unit
V <sub>CC</sub>	$V_{CC}$	Positive DC Supply Voltage	-0.5 to 5.5		V
V <sub>IS</sub>	NOx, NCx, COMx	Analog Signal Voltage	-0.5 to V <sub>CC</sub> + 0.5		V
V <sub>IN</sub>	IN1, IN2	Control Input Voltage	-0.5 to 5.5		V
I <sub>CC</sub>	$V_{CC}$	Positive DC Supply Current	50		mA
I <sub>IS_CON</sub>	NOx, NCx, COMx	Analog Signal Continues Current	±300	Closed Switch	mA
lis_pk	NOx, NCx, COMx	Analog Signal Peak Current	±500	10% Duty Cycle	mA
I <sub>IN</sub>	IN	Control Input Current	±20		mA
T <sub>STG</sub>		Storage Temperature Range	-65 to 150		ōС

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

#### **RECOMMENDED OPERATING CONDITIONS\***

Symbol	Pins	Parameter	Value	Condition	Unit
V <sub>CC</sub>	V <sub>CC</sub>	Positive DC Supply Voltage	1.65 to 4.5		V
V <sub>IS</sub>	NOx, NCx, COMx	Analog Signal Voltage	0 to V <sub>CC</sub>		V
V <sub>IN</sub>	IN1, IN2	Control Input Voltage	0 to V <sub>CC</sub>		V
T <sub>A</sub>		Operating Temperature Range	-40 to 85		∘C

Minimum and maximum values are guaranteed through test or design across the **Recommended Operating Conditions**, where applicable. Typical values are listed for guidance only and are based on the particular conditions listed for each section, where applicable. These conditions are valid for all values found in the characteristics tables unless otherwise specified in the test conditions.

#### **ESD PROTECTION**

Symbol	Parameter	Value	Unit
ESD	Human Body Model I/O to GND All Pins	8.0 4.0	kV

#### DC ELECTRICAL CHARACTERISTICS

**CONTROL INPUT** (Typical: T =  $25^{\circ}$ C,  $V_{CC} = 3.3 \text{ V}$ )

					–40°C to +85°C			
Symbol	Pins	Parameter	Test Conditions	V <sub>CC</sub> (V)	Min	Тур	Max	Unit
V <sub>IH</sub>	ŌĒ	Control Input HIGH Voltage		2.7 3.3 4.2	1.4 1.7 2.3	-	-	V
V <sub>IL</sub>	ŌĒ	Control Input LOW Voltage		2.7 3.3 4.2	-	-	0.5 0.5 0.8	V
I <sub>IN</sub>	ŌĒ	Control Input Leakage Current	$0 \le V_{IS} \le V_{CC}$	1.65 – 4.5	-	-	±1.0	μΑ

#### **SUPPLY CURRENT AND LEAKAGE** (Typical: T = 25°C, $V_{CC} = 3.3 \text{ V}$ )

					–40°C to +85°C			
Symbol	Pins	Parameter	Test Conditions	V <sub>CC</sub> (V)	Min	Тур	Max	Unit
I <sub>CC</sub>	V <sub>CC</sub>	Quiescent Supply Current	$V_{IS} = V_{CC}$ or GND; $I_D = 0$ A	1.65 – 4.5	-	=	1.0	μΑ
I <sub>CCT</sub>	V <sub>CC</sub>	Increase in I <sub>CC</sub> per Control Voltage	V <sub>IN</sub> = 2.6 V	3.6	_	-	10.0	μΑ
I <sub>OZ</sub>		OFF State Leakage	$0 \le V_{IS} \le V_{CC}$	1.65 – 4.5	_	-	±1.0	μΑ
I <sub>OFF</sub>	D+, D-	Power OFF Leakage Current	$0 \le V_{IS} \le V_{CC}$	0	ı	-	±1.0	μΑ

#### ON RESISTANCE (Typical: T = 25°C, V<sub>CC</sub> = 3.3 V)

					-40	0°C to +85	°C	
Symbol	Pins	Parameter	Test Conditions	V <sub>CC</sub> (V)	Min	Тур	Max	Unit
R <sub>ON</sub>		On-Resistance	$I_{ON}$ = -100 mA $V_{IS}$ = 0 to $V_{CC}$	2.7 3.3 4.2	ı		2.0 1.4 1.3	Ω
R <sub>FLAT</sub>		On-Resistance Flatness	$I_{ON}$ = -100 mA $V_{IS}$ = 0 to $V_{CC}$	2.7 3.3 4.2	-	0.32 0.35 0.37	-	Ω
ΔR <sub>ON</sub>		On–Resistance Matching	$I_{ON}$ = -100 mA $V_{IS}$ = 0 to $V_{CC}$	2.7 3.3 4.2	-	0.16 0.16 0.15	-	Ω

#### **AC ELECTRICAL CHARACTERISTICS**

#### **TIMING/FREQUENCY** (Typical: T = 25°C, $V_{CC}$ = 3.3 V, $R_L$ = 50 $\Omega$ , $C_L$ = 5 pF, f = 1 MHz)

					-40	-40°C to +85°C		
Symbol	Pins	Parameter	Test Conditions	V <sub>CC</sub> (V)	Min	Тур	Max	Unit
t <sub>ON</sub>	Closed to Open	Turn-ON Time		1.65 – 4.5	1	20	Ì	ns
t <sub>OFF</sub>	Open to Closed	Turn-OFF Time		1.65 – 4.5	-	15	-	ns
BW		-3 dB Bandwidth	C <sub>L</sub> = 5 pF	1.65 – 4.5	_	496	_	MHz

#### **ISOLATION** (Typical: T = 25°C, $V_{CC}$ = 3.3 V, $R_L$ = 50 $\Omega$ , $C_L$ = 5 pF, f = 1 MHz)

					-40°C to +85°C			
Symbol	Pins	Parameter	Test Conditions	V <sub>CC</sub> (V)	Min	Тур	Max	Unit
O <sub>IRR</sub>	Open	OFF-Isolation		1.65 – 4.5	_	-57	-	dB
X <sub>TALK</sub>	HSD+, HSD-	Non-Adjacent Channel Crosstalk		1.65 – 4.5	-	-97	1	dB

### $\textbf{CAPACITANCE} \text{ (Typical: } T = 25^{\circ}\text{C, V}_{CC} = 3.3 \text{ V, R}_{L} = 50 \text{ }\Omega\text{, C}_{L} = 5 \text{ pF, f} = 1 \text{ MHz)}$

				-40°C to +85°C			
Symbol	Pins	Parameter	Test Conditions	Min	Тур	Max	Unit
C <sub>IN</sub>	ŌĒ	Control Pin Input Capacitance	V <sub>CC</sub> = 0 V	_	8.5	-	pF
C <sub>ON</sub>	HSD+, to D+	ON Capacitance	V <sub>IN</sub> = 0 V	-	32	-	pF
C <sub>OFF</sub>	HSD+, HSD-	OFF Capacitance	$V_{IS} = 3.3 \text{ V}; V_{IN} = 3.3 \text{ V}$	_	19	-	pF

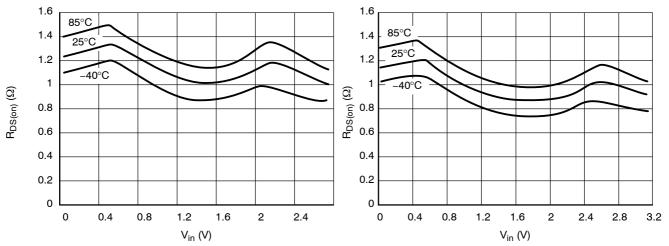


Figure 3.  $R_{ON}$  @  $V_{CC}$  = 2.7 V

Figure 4. R<sub>ON</sub> @  $V_{CC}$  = 3.3 V

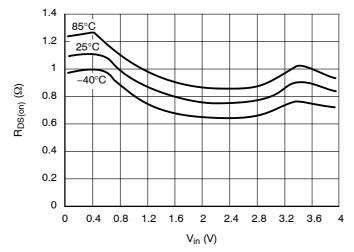


Figure 5. R<sub>ON</sub> @ V<sub>CC</sub> = 4.2 V

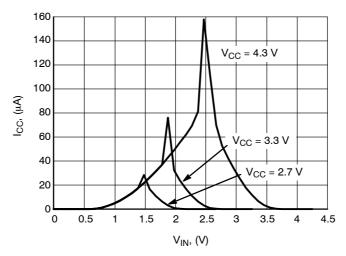
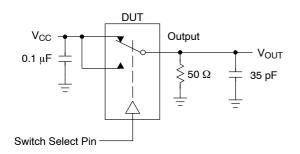


Figure 6.  $I_{CC}$  vs.  $V_{IN}$ 



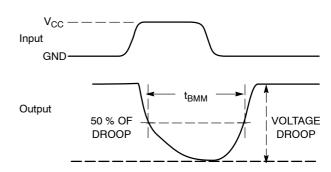
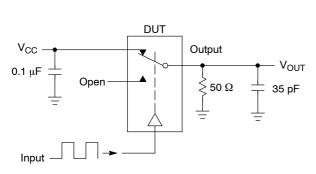


Figure 7. t<sub>BBM</sub> (Time Break-Before-Make)



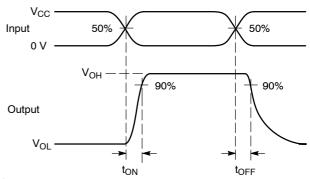
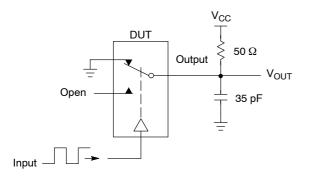


Figure 8. t<sub>ON</sub>/t<sub>OFF</sub>



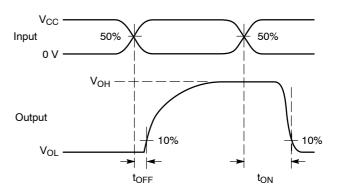
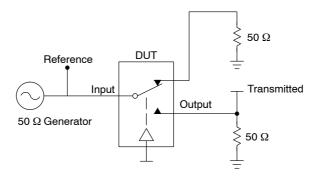


Figure 9. t<sub>ON</sub>/t<sub>OFF</sub>



Channel switch control/s test socket is normalized. Off isolation is measured across an off channel. On loss is the bandwidth of an On switch.  $V_{ISO}$ , Bandwidth and  $V_{ONL}$  are independent of the input signal direction.

$$V_{ISO}$$
 = Off Channel Isolation = 20 Log  $\left(\frac{V_{OUT}}{V_{IN}}\right)$  for  $V_{IN}$  at 100 kHz

$$V_{ONL}$$
 = On Channel Loss = 20 Log  $\left(\frac{V_{OUT}}{V_{IN}}\right)$  for  $V_{IN}$  at 100 kHz to 50 MHz

Bandwidth (BW) = the frequency 3 dB below  $V_{ONL}$ 

 $V_{CT}$  = Use  $V_{ISO}$  setup and test to all other switch analog input/outputs terminated with 50  $\Omega$ 

Figure 10. Off Channel Isolation/On Channel Loss (BW)/Crosstalk (On Channel to Off Channel)/V<sub>ONL</sub>

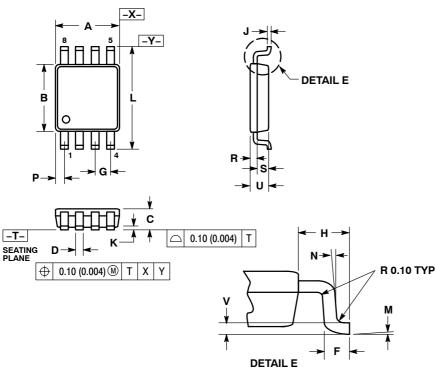
#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package Type	Shipping <sup>†</sup>
NLAS5213AUSG	VD	US8 (Pb-Free)	3,000 / Tape & Reel
NLAS5213AMUTAG	VD	UDFN8 (Pb-Free)	3,000 / Tape & Reel
NLAS5213BUSG	VE	US8 (Pb-Free)	3,000 / Tape & Reel
NLAS5213BMUTAG	VE	UDFN8 (Pb-Free)	3,000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

#### US8 CASE 493-02 **ISSUE B**



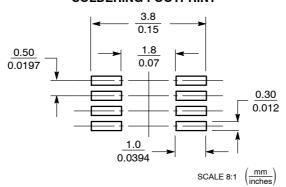
- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION "A" DOES NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURR. MOLD FLASH. PROTRUSION AND GATE BURR SHALL NOT EXCEED 0.140 MM (0.0055") PER SIDE.
  4. DIMENSION "B" DOES NOT INCLUDE INTER-LEAD FLASH OR PROTRUSION. INTER-LEAD FLASH AND PROTRUSION SHALL NOT E3XCEED 0.140 (0.0055") PER
- SHALL NOT E3XCEED 0.140 (0.0055") PER SIDE.
- SIDE.

  5. LEAD FINISH IS SOLDER PLATING WITH THICKNESS OF 0.0076-0.0203 MM.
- (300–800 ").

  6. ALL TOLERANCE UNLESS OTHERWISE SPECIFIED ±0.0508 (0.0002 ").

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	1.90	2.10	0.075	0.083	
В	2.20	2.40	0.087	0.094	
С	0.60	0.90	0.024	0.035	
D	0.17	0.25	0.007	0.010	
F	0.20	0.35	0.008	0.014	
G	0.50	0.50 BSC 0.020 BSC			
Н	0.40 REF (		0.016	016 REF	
J	0.10	0.18	0.004	0.007	
K	0.00	0.10	0.000	0.004	
L	3.00	3.20	0.118	0.126	
М	0°	6 °	0 °	6 °	
N	5 °	10 °	5 °	10 °	
P	0.23	0.34	0.010	0.013	
R	0.23	0.33	0.009	0.013	
S	0.37	0.47	0.015	0.019	
U	0.60	0.80	0.024	0.031	
V	0.12 BSC		0.005 BSC		

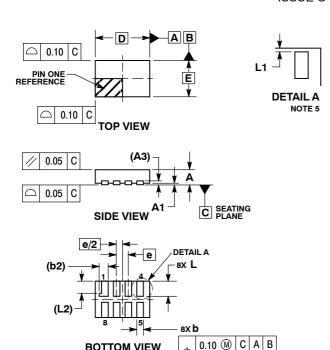
#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

#### UDFN8 1.8x1.2, 0.4P CASE 517AJ-01 ISSUE O



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0.05 M

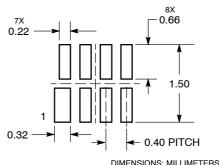
C NOTE 3

**BOTTOM VIEW** 

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION & APPLIES TO PLATED
- TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM TERMINAL TIP.
- MOLD FLASH ALLOWED ON TERMINALS ALONG EDGE OF PACKAGE. FLASH MAY NOT EXCEED 0.03 ONTO BOTTOM SURFACE OF TERMINALS.
- DETAIL A SHOWS OPTIONAL CONSTRUCTION FOR TERMINALS.

	MILLIMETERS		
	MILLIMETERS		
DIM	MIN	MAX	
Α	0.45	0.55	
A1	0.00	0.05	
А3	0.127 REF		
b	0.15	0.25	
b2	0.30 REF		
D	D 1.80 BSC		
Е	1.20	BSC	
е	0.40 BSC		
L	0.45	0.55	
L1	0.00	0.03	
L2	0.40 REF		

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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